

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/656,639	DURRANT, PAUL	
Examiner	Art Unit	
Vaima Campos	2185	

SEARCHED				
Class	Subclass	Date	Examiner	
			1,144	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		
				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EIC PLUS Search	10/18/2005	YC		
EAST Text Search, PALM search, and Inventor name search	10/25/2005	YC		
Consulted Search Mentor Matthew Anderson	10/25/2005	YC		
Text Search within subclasses 711/165,141,154,210	10/30/2005	YC		